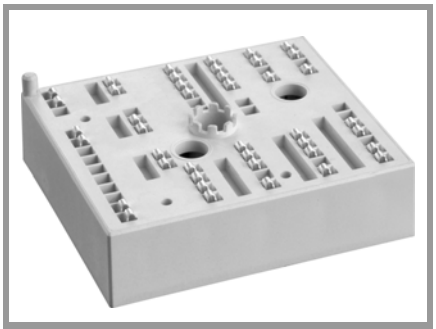
SKiiP 28TMLI12F4V1



MiniSKiiP® 2

3-Level TNPC IGBT-Module

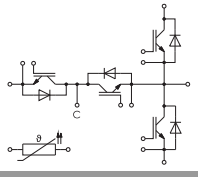
SKiiP 28TMLI12F4V1

Features*

- Fast Trench 4 IGBTs
- Trench IGBTs
- Robust and soft diodes in CAL technology
- Highly reliable spring contacts for electrical connections
- UL recognised: File no. E63532

Remarks*

- Case temperature limited to T_C=125°C max.; $T_C = T_S$ (for baseplateless modules)
- Product reliability results valid for T_j≤150°C (recommended T_{jop}=-40...+150°C)
- IGBT 1: outer IGBTs T1&T4
- IGBT 2: inner IGBTs T2&T3
- Diode 1: outer diodes D1&D4
- Diode 2: inner diodes D2&D3



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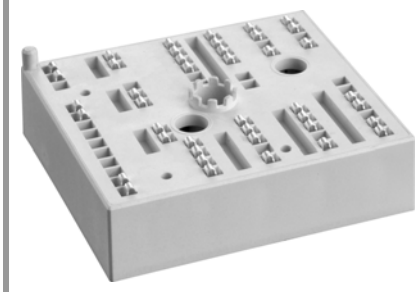
Absolute Maximum Ratings

Symbol	Conditions		Values	Unit
IGBT1				
V_{CES}	T_j = 25 °C		1200	V
I_C	T_j = 175 °C	T_s = 25 °C	93	A
		T_s = 70 °C	76	A
I_{Cnom}			80	A
I_{CRM}			240	A
V_{GES}			-20 ... 20	V
t_{psc}	V_{CC} = 800 V, V_{GE} ≤ 15 V, T_j = 150 °C, V_{CES} ≤ 1200 V		10	µs
T_j			-40 ... 175	°C
IGBT2				
V_{CES}	T_j = 25 °C		650	V
I_C	T_j = 175 °C	T_s = 25 °C	77	A
		T_s = 70 °C	61	A
I_{Cnom}			75	A
I_{CRM}			225	A
V_{GES}			-20 ... 20	V
t_{psc}	V_{CC} = 360 V, V_{GE} ≤ 15 V, T_j = 150 °C, V_{CES} ≤ 650 V		6	µs
T_j			-40 ... 175	°C
Diode1				
V_{RRM}	T_j = 25 °C		1200	V
I_F	T_j = 175 °C	T_s = 25 °C	76	A
		T_s = 70 °C	61	A
I_{FRM}			150	A
I_{FSM}	10 ms, sin 180°, T_j = 25 °C		430	A
T_j			-40 ... 175	°C
Diode2				
V_{RRM}	T_j = 25 °C		650	V
I_F	T_j = 175 °C	T_s = 25 °C	65	A
		T_s = 70 °C	51	A
I_{FRM}			100	A
I_{FSM}	10 ms, sin 180°, T_j = 25 °C		550	A
T_j			-40 ... 175	°C
Module				
$I_{t(RMS)}$	20 A per spring		80	A
T_{stg}	module without TIM		-40 ... 125	°C
V_{isol}	AC sinus 50 Hz, t = 1 min		2500	V

SKiiP 28TMLI12F4V1



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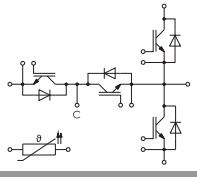
- IGBT 1: outer IGBTs T1&T4
- IGBT 2: inner IGBTs T2&T3
- Diode 1: outer diodes D1&D4
- Diode 2: inner diodes D2&D3

Characteristics

Symbol	Conditions		min.	typ.	max.	Unit
IGBT1						
$V_{CE(sat)}$	I_C = 80 A V_{GE} = 15 V chiplevel	T_j = 25 °C		2.05	2.40	V
		T_j = 150 °C		2.59	2.85	V
V_{CE0}	chiplevel	T_j = 25 °C		0.80	0.90	V
		T_j = 150 °C		0.70	0.80	V
r_{CE}	V_{GE} = 15 V chiplevel	T_j = 25 °C		16	19	mΩ
		T_j = 150 °C		24	26	mΩ
$V_{GE(th)}$	$V_{GE} = V_{CE}$, I_C = 1 mA		5.2	5.8	6.4	V
I_{CES}	V_{GE} = 0 V, V_{CE} = 1200 V, T_j = 25 °C				1	mA
C_{ies}	V_{CE} = 25 V V_{GE} = 0 V	f = 1 MHz		4.60		nF
C_{oes}		f = 1 MHz		0.37		nF
C_{res}		f = 1 MHz		0.27		nF
Q_G	V_{GE} = - 8 V...+ 15 V			454		nC
R_{Gint}	T_j = 25 °C			4.0		Ω
$t_{d(on)}$	V_{CE} = 300 V I_C = 80 A V_{GE} = +15/-15 V $R_{G\ on}$ = 1.6 Ω $R_{G\ off}$ = 1.6 Ω di/dt_{on} = 1330 A/µs di/dt_{off} = 1220 A/µs	T_j = 150 °C		168		ns
t_r		T_j = 150 °C		54		ns
E_{on}		T_j = 150 °C		3.4		mJ
$t_{d(off)}$		T_j = 150 °C		285		ns
t_f		T_j = 150 °C		58		ns
E_{off}		T_j = 150 °C		2.2		mJ
$R_{th(j-s)}$	per IGBT, λ_{paste}=0.8 W/(K*m)			0.49		K/W
IGBT2						
$V_{CE(sat)}$	I_C = 75 A V_{GE} = 15 V chiplevel	T_j = 25 °C		1.45	1.77	V
		T_j = 150 °C		1.70	2.10	V
V_{CE0}	chiplevel	T_j = 25 °C		0.90	1.00	V
		T_j = 150 °C		0.82	0.90	V
r_{CE}	V_{GE} = 15 V chiplevel	T_j = 25 °C		7.3	10	mΩ
		T_j = 150 °C		12	16	mΩ
$V_{GE(th)}$	$V_{GE} = V_{CE}$, I_C = 1.2 mA		5.1	5.8	6.4	V
I_{CES}	V_{GE} = 0 V, V_{CE} = 650 V, T_j = 25 °C				1	mA
C_{ies}	V_{CE} = 25 V V_{GE} = 0 V	f = 1 MHz		4.62		nF
C_{oes}		f = 1 MHz		0.30		nF
C_{res}		f = 1 MHz		0.14		nF
Q_G	V_{GE} = - 8 V...+ 15 V			680		nC
R_{Gint}	T_j = 25 °C			4.0		Ω
$t_{d(on)}$	V_{CE} = 300 V I_C = 75 A V_{GE} = +15/-15 V $R_{G\ on}$ = 1.6 Ω $R_{G\ off}$ = 1.6 Ω di/dt_{on} = 2600 A/µs di/dt_{off} = 1000 A/µs	T_j = 150 °C		84		ns
t_r		T_j = 150 °C		33		ns
E_{on}		T_j = 150 °C		1.6		mJ
$t_{d(off)}$		T_j = 150 °C		212		ns
t_f		T_j = 150 °C		65		ns
E_{off}		T_j = 150 °C		1.9		mJ
$R_{th(j-s)}$	per IGBT, λ_{paste}=0.8 W/(K*m)			0.89		K/W



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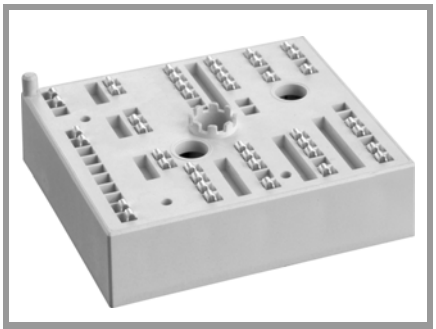

MiniSKiiP® 2

3-Level TNPC IGBT-Module

SKiiP 28TMLI12F4V1

Features*

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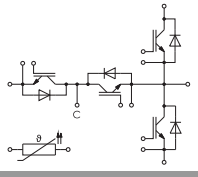
- IGBT 1: outer IGBTs T1&T4
- IGBT 2: inner IGBTs T2&T3
- Diode 1: outer diodes D1&D4
- Diode 2: inner diodes D2&D3

Characteristics

Symbol	Conditions		min.	typ.	max.	Unit
Diode1						
$V_F = V_{EC}$	I_F = 75 A V_{GE} = 0 V chiplevel	T_j = 25 °C		2.17	2.49	V
		T_j = 150 °C		2.11	2.42	V
V_{F0}	chiplevel	T_j = 25 °C		1.30	1.50	V
		T_j = 150 °C		0.90	1.10	V
r_F	chiplevel	T_j = 25 °C		12	13	mΩ
		T_j = 150 °C		16	18	mΩ
I_{RRM}	I_F = 75 A di/dt_{off} = 2360 A/µs V_R = 300 V V_{GE} = +15/-15 V	T_j = 150 °C		115		A
Q_{rr}		T_j = 150 °C		8.9		µC
E_{rr}		T_j = 150 °C		1.7		mJ
$R_{th(j-s)}$	per Diode, λ_{paste}=0.8 W/(K*m)			0.86		K/W
Diode2						
$V_F = V_{EC}$	I_F = 50 A V_{GE} = 0 V chiplevel	T_j = 25 °C		1.37	1.73	V
		T_j = 150 °C		1.35	1.72	V
V_{F0}	chiplevel	T_j = 25 °C		1.04	1.24	V
		T_j = 150 °C		0.85	0.99	V
r_F	chiplevel	T_j = 25 °C		6.7	9.8	mΩ
		T_j = 150 °C		10	15	mΩ
I_{RRM}	I_F = 50 A di/dt_{off} = 1250 A/µs V_R = 300 V V_{GE} = +15/-15 V	T_j = 125 °C		48.7		A
Q_{rr}		T_j = 125 °C		5		µC
E_{rr}		T_j = 125 °C		0.7		mJ
$R_{th(j-s)}$	per Diode, λ_{paste}=0.8 W/(mK)			1.25		K/W
Module						
L_{sCE1}				-		nH
L_{CE}				-		nH
$R_{CC'+EE'}$		T_s = 25 °C		-		mΩ
		T_s = 125 °C		-		mΩ
M_s	to heat sink		2		2.5	Nm
w				55		g
Temperature Sensor						
R_{100}	T_r=100°C (R_{25}=1000Ω)			1670 ± 3%		Ω
$R_{(T)}$	$R_{(T)}$=1000Ω[1+A(T-25°C)+B(T-25°C)^2] , A = 7.635*10^{-3}°C^{-1} °C^{-1}, B = 1.731*10^{-5}°C^{-2} °C^{-2}					



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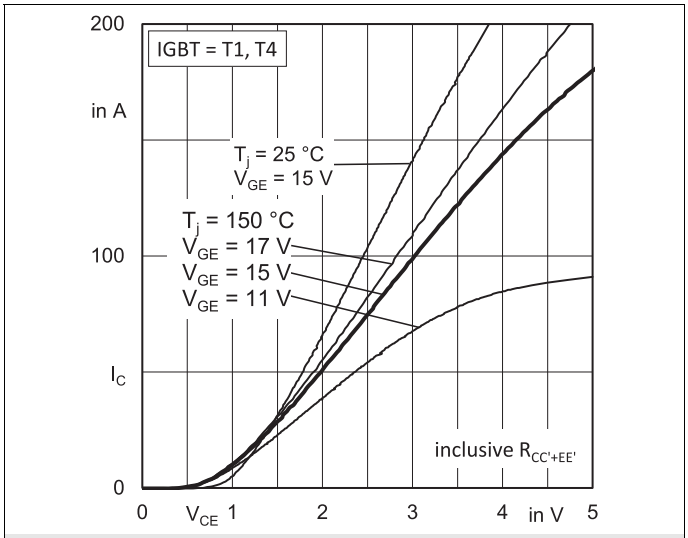


Fig. 1: Typ. IGBT1 output characteristic, incl. $R_{CC'+EE'}$

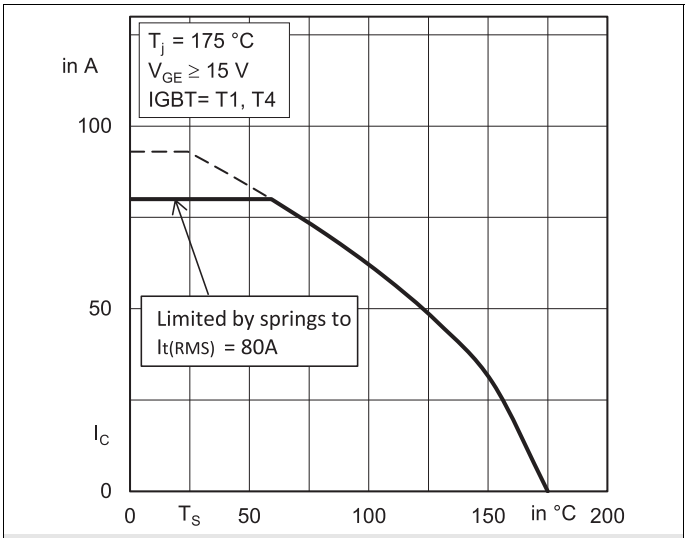


Fig. 2: IGBT1 rated current vs. Temperature $I_c=f(T_s)$

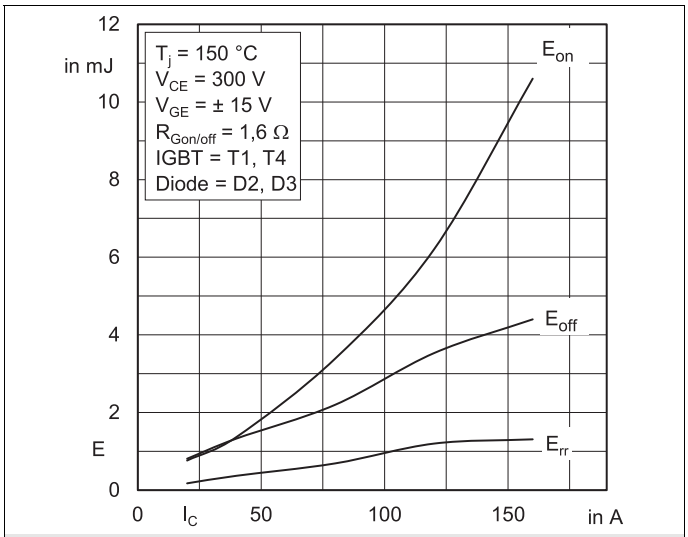


Fig. 3: Typ. IGBT1 & Diode2 turn-on /-off energy = f (I_C)

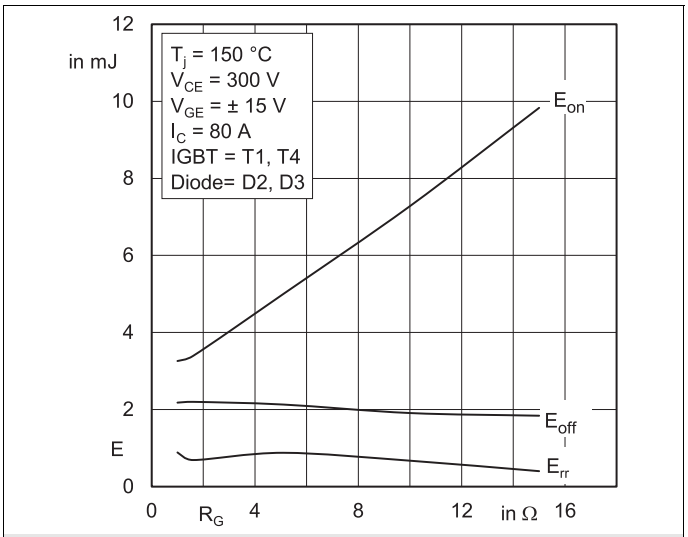


Fig. 4: Typ. IGBT1 & Diode2 turn-on /-off energy = f(R_G)

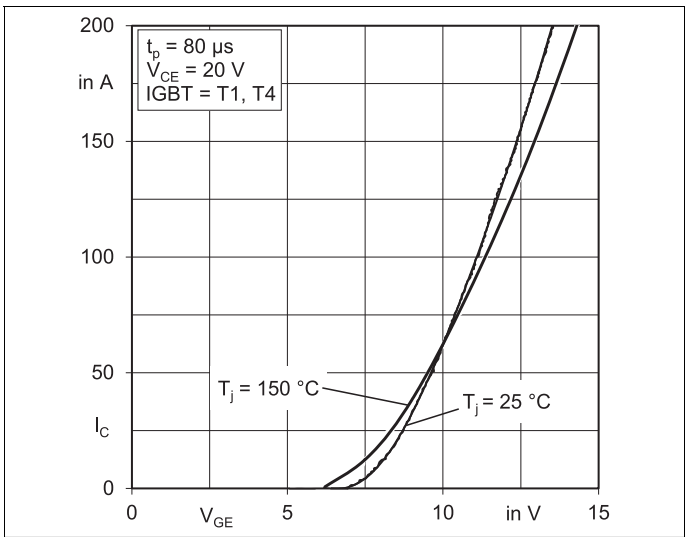


Fig. 5: Typ. IGBT1 transfer characteristic

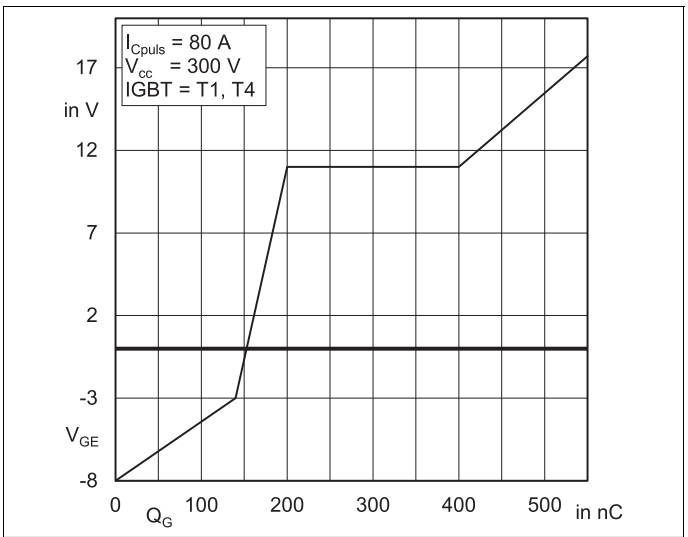


Fig. 6: Typ. IGBT1 gate charge characteristic

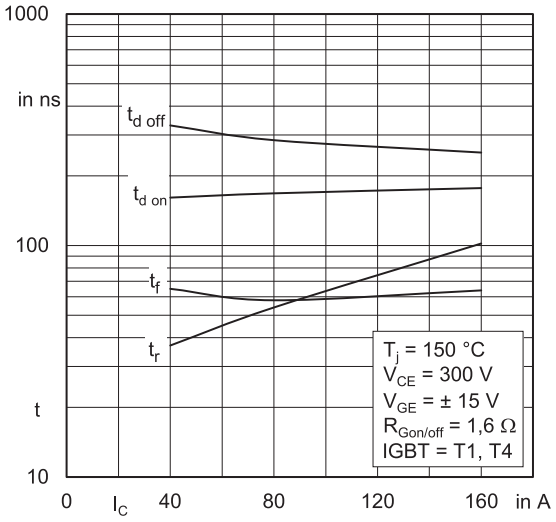


Fig. 7: Typ. IGBT1 switching times vs. I_C

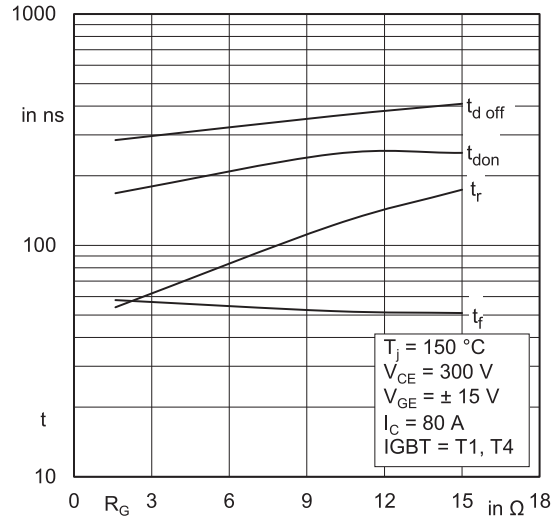


Fig. 8: Typ. IGBT1 switching times vs. gate resistor R_G

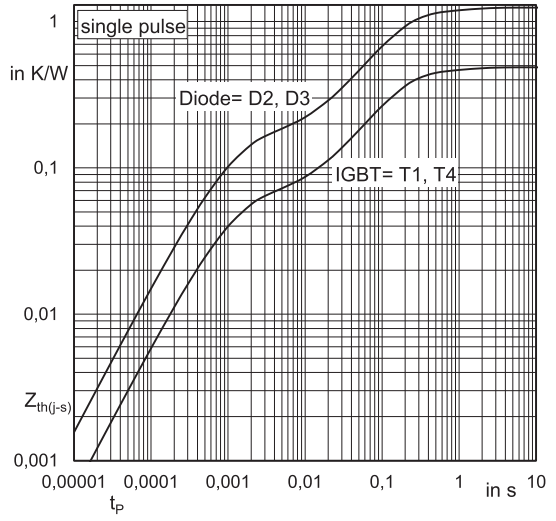


Fig. 9: Typ. Transient thermal impedance of IGBT1 & Diode2

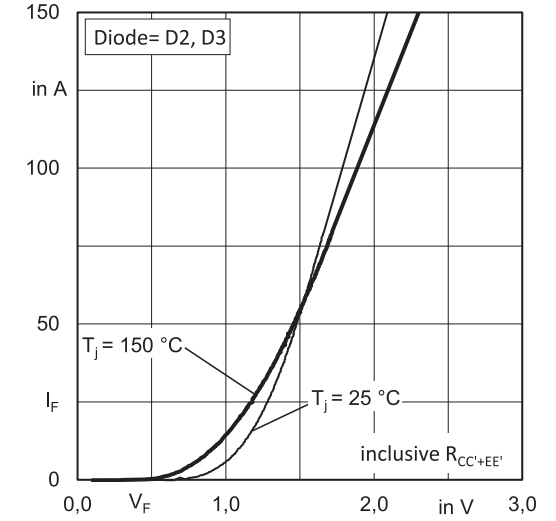


Fig. 10: Typ. Diode2 forward characteristic, incl. $R_{CC'+EE'}$

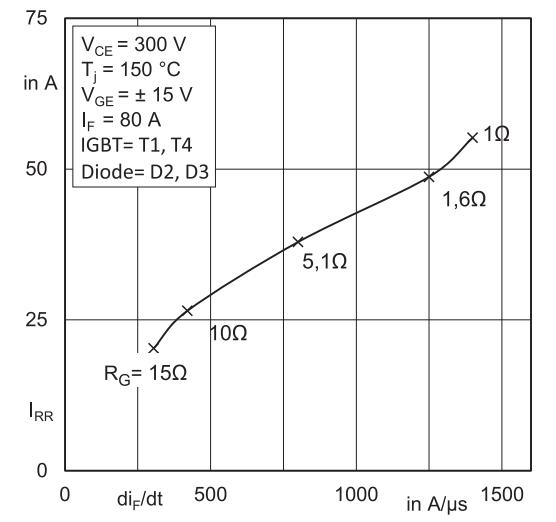


Fig. 11: Typ. Diode2 peak reverse recovery current

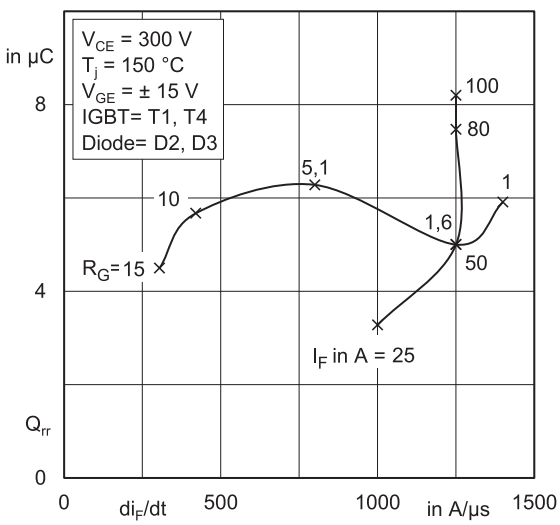


Fig. 12: Typ. Diode2 recovery charge

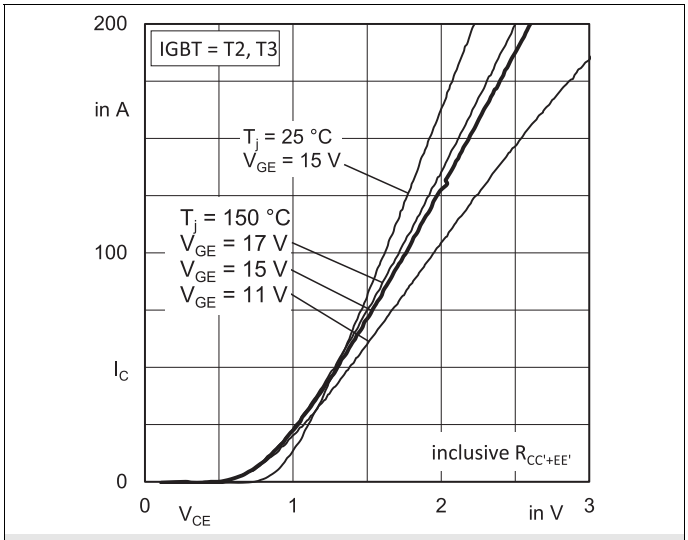


Fig. 13: Typ. IGBT2 output characteristic, incl. $R_{CC'+EE'}$

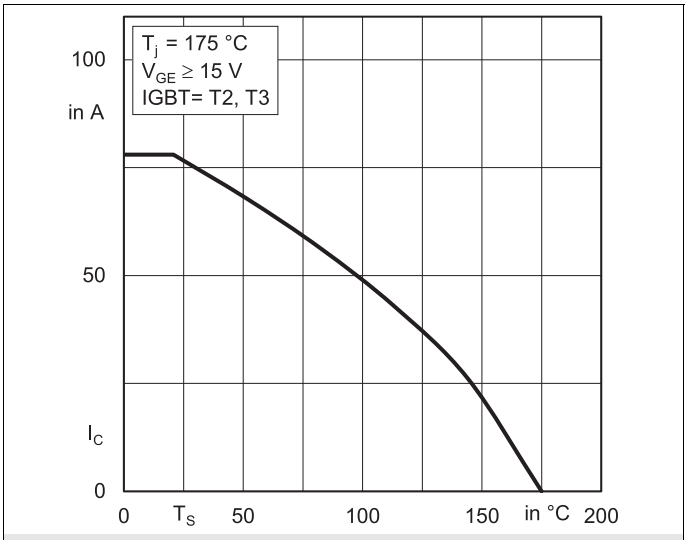


Fig. 14: IGBT2 Rated current vs. Temperature $I_c = f(T_s)$

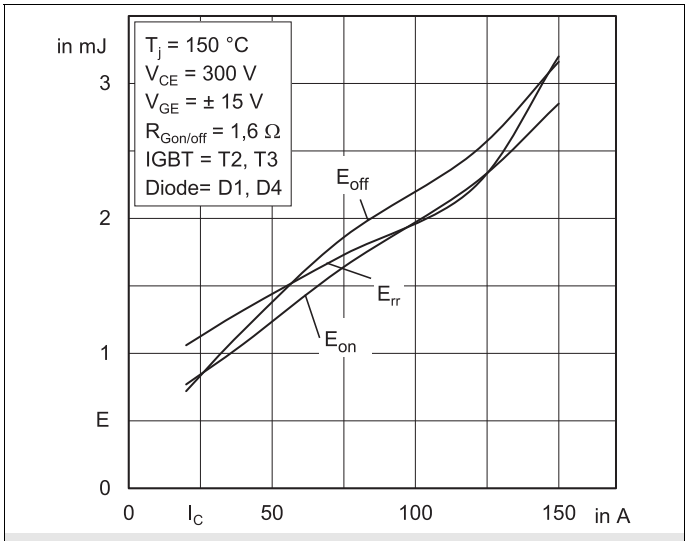


Fig. 15: Typ. IGBT2 & Diode1 turn-on /-off energy = f (I_C)

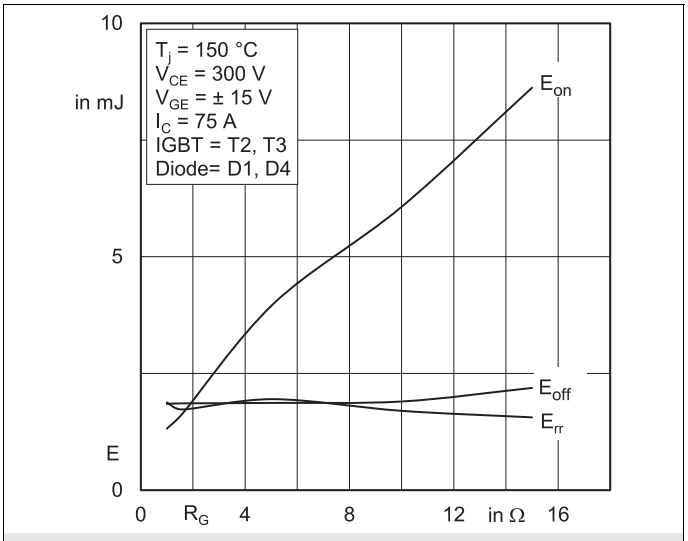


Fig. 16: Typ. IGBT2 & Diode1 turn-on / -off energy = f(R_G)

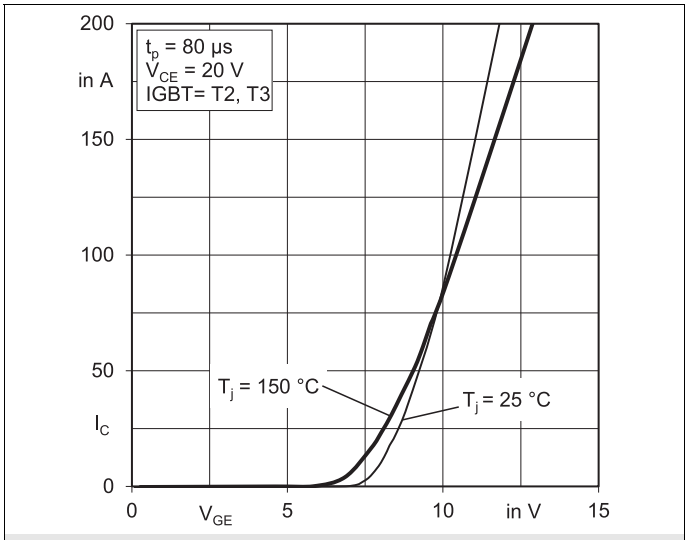


Fig. 17: Typ. IGBT2 transfer characteristic

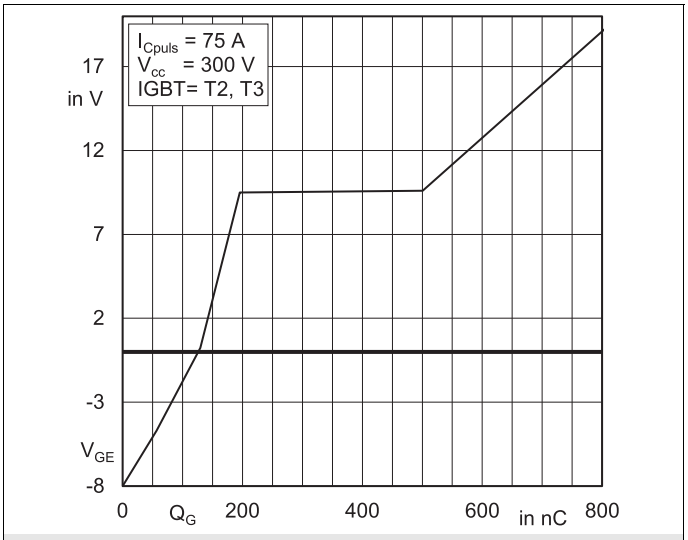


Fig. 18: Typ. IGBT2 gate charge characteristic

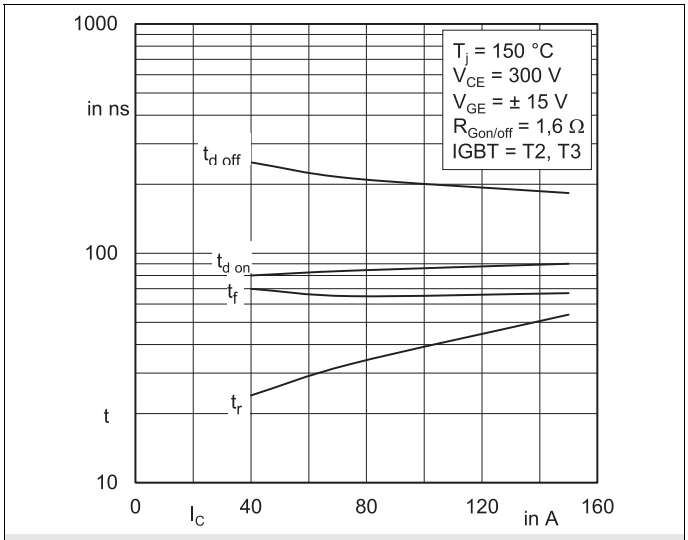


Fig. 19: Typ. IGBT2 switching times vs. I_C

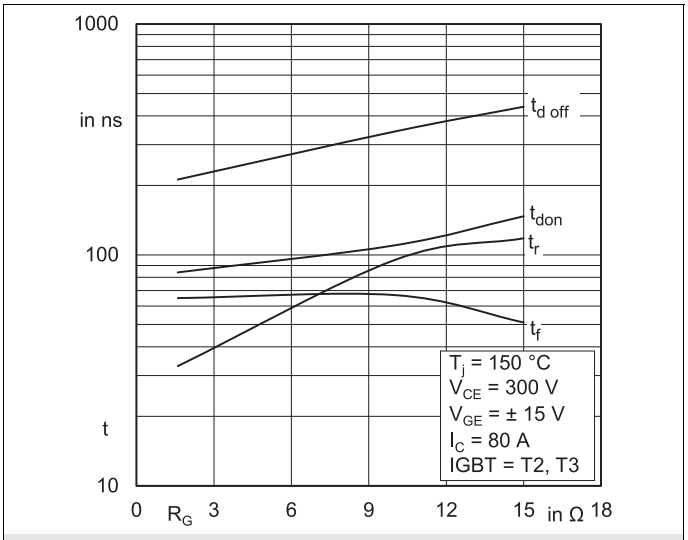


Fig. 20: Typ. IGBT2 switching times vs. gate resistor R_G

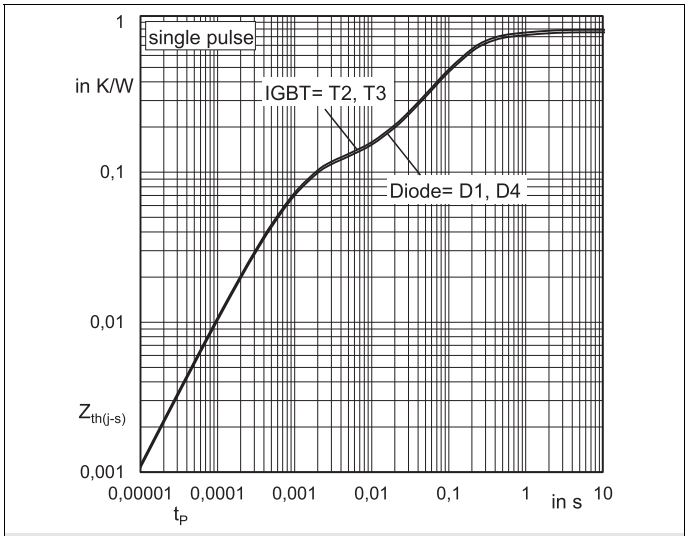


Fig. 21: Transient thermal impedance of IGBT2 & Diode1

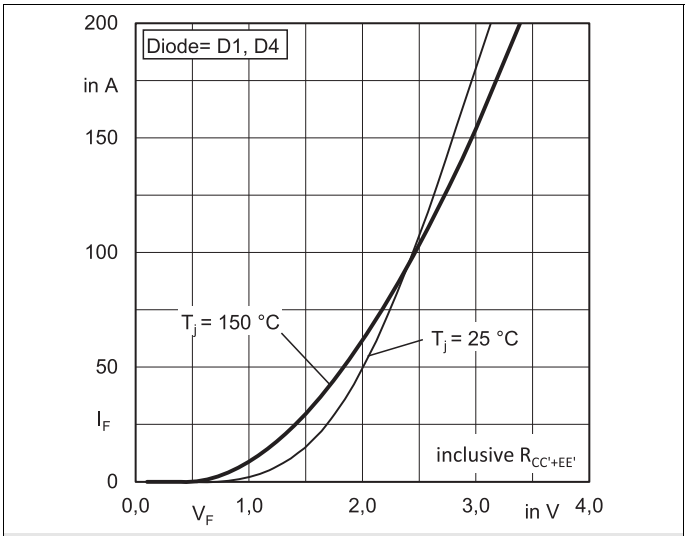


Fig. 22: Typ. Diode1 forward characteristic, incl. $R_{CC'+EE'}$

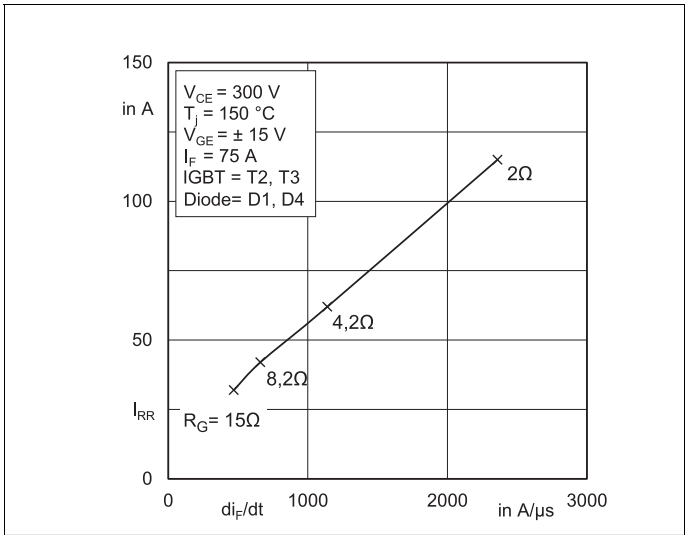


Fig. 23: Typ. Diode1 peak reverse recovery current

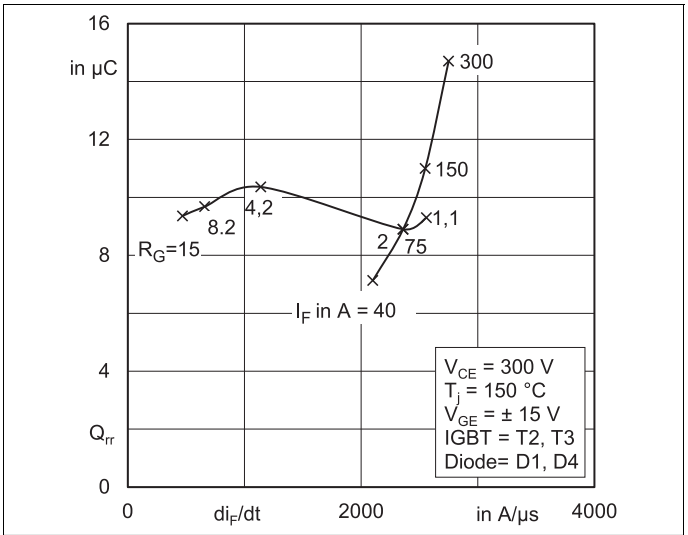
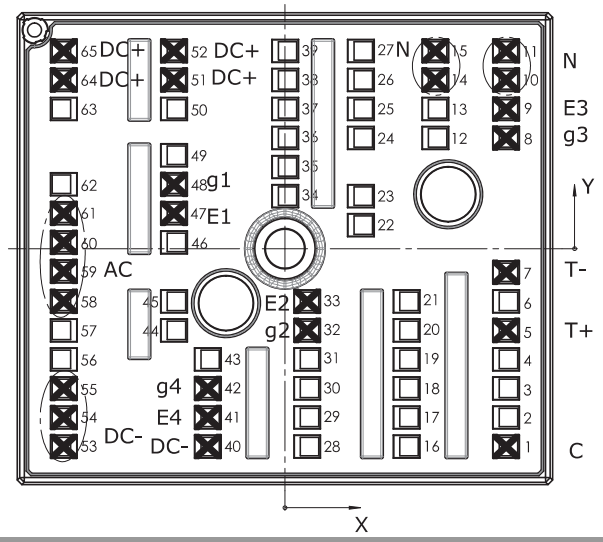


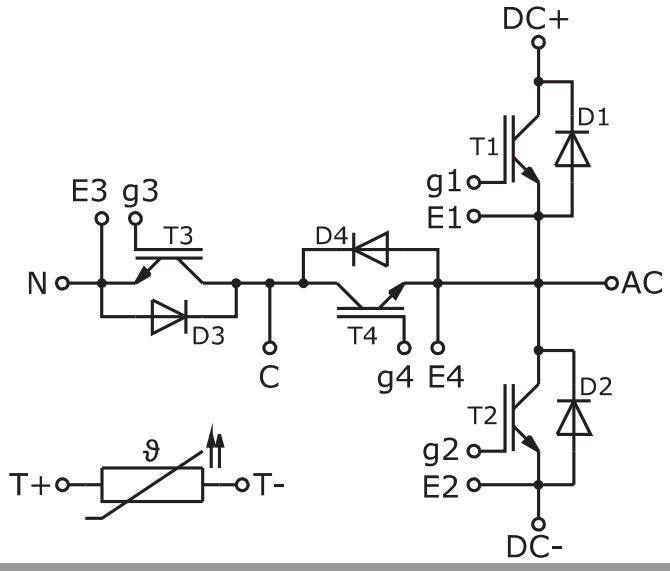
Fig. 24: Typ. Diode1 recovery charge

Pin out											
Pin	*X*	*Y*	*Function*	*Pin*	*X*	*Y*	*Function*	*Pin*	*X*	*Y*	*Function*
1	24,38	-21,80	C	23	8,38	5,80		45	-12,23	-5,80	
2	24,38	-18,60		24	8,38	12,20		46	-12,23	0,70	
3	24,38	-15,40		25	8,38	15,40		47	-12,23	3,90	E1
4	24,38	-12,20		26	8,38	18,60		48	-12,23	7,10	g1
5	24,38	-9,00	T+	27	8,38	21,80		49	-12,23	10,30	
6	24,38	-5,80		28	2,46	-21,80		50	-12,23	15,40	
7	24,38	-2,60	T-	29	2,46	-18,60		51	-12,23	18,60	DC+
8	24,38	12,20	g3	30	2,46	-15,40		52	-12,23	21,80	DC+
9	24,38	15,40	E3	31	2,46	-12,20		53	-24,38	-21,80	DC-
10	24,38	18,60	N	32	2,46	-9,00	g2	54	-24,38	-18,60	DC-
11	24,38	21,80	N	33	2,46	-5,80	E2	55	-24,38	-15,40	DC-
12	16,58	12,20		34	0,03	5,80		56	-24,38	-12,20	
13	16,58	15,40		35	0,03	9,00		57	-24,38	-9,00	
14	16,58	18,60	N	36	0,03	12,20		58	-24,38	-5,80	AC
15	16,58	21,80	N	37	0,03	15,40		59	-24,38	-2,50	AC
16	13,42	-21,80		38	0,03	18,60		60	-24,38	0,70	AC
17	13,42	-18,60		39	0,03	21,80		61	-24,38	3,90	AC
18	13,42	-15,40		40	-8,51	-21,80	DC-	62	-24,38	7,10	
19	13,42	-12,20		41	-8,51	-18,60	E4	63	-24,38	15,40	
20	13,42	-9,00		42	-8,51	-15,40	g4	64	-24,38	18,60	DC+
21	13,42	-5,80		43	-8,51	-12,20		65	-24,38	21,80	DC+
22	8,38	2,60		44	-12,23	-9,00					

all values in mm



Pinout and Dimensions



Pinout

This is an electrostatic discharge sensitive device (ESDS) due to international standard IEC 61340.

***IMPORTANT INFORMATION AND WARNINGS**

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